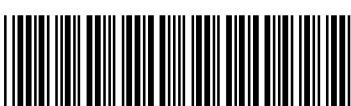


Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10767468	HAN, HEE-CHUL
	Examiner	Art Unit
	Reyes, Mariela D	2167

SEARCHED

Class	Subclass	Date	Examiner
707	4	12/8/2006	MR

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search (Palm)	12/8/2006	MR
East Search	12/8/2006	MR
NPL Search (Google, TIVO)	12/9/2006	MR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner